

Notice of References Cited

Application/Control No.

09/914,404

Applicant(s)/Patent Under
Reexamination
SPITZ ET AL.

Examiner

Michelle Estrada

Art Unit

2823

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,099,997 A	07-1978	Rosnowski, Wojciech	438/133
	B	US-5,496,765 A	03-1996	Schwalke, Udo	438/404
	C	US-4,889,492 A	12-1989	Barden et al.	438/247
	D	US-6,360,685 B1	03-2002	Xia et al.	118/695
	E	US-6,057,216 A	05-2000	Economikos et al.	438/249
	F	US-6,057,251 A	05-2000	Goo et al.	438/487
	G	US-5,770,490 A	06-1998	Frenette et al.	438/168
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 59080928 A	05-1984	Japan	Shinohara, Mamoru	H01L 21/22
	O	JP 61064125 A	04-1986	Japan	Kakiuchi et al.	H01L 21/22
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.